

## Precision Monolithic Quad SPST CMOS Analog Switches

### DESCRIPTION

The DG417B, DG418B, DG419B monolithic CMOS analog switches were designed to provide high performance switching of analog signals. Combining low power, low leakages, high speed, low on-resistance and small physical size, the DG417B series is ideally suited for portable and battery powered industrial and military applications requiring high performance and efficient use of board space.

To achieve high-voltage ratings and superior switching performance, the DG417B series is built on Vishay Siliconix's high voltage silicon gate (HVSG) process. Break-before-make is guaranteed for the DG419B, which is an SPDT configuration. An epitaxial layer prevents latchup.

Each switch conducts equally well in both directions when on, and blocks up to the power supply level when off.

The DG417B and DG418B respond to opposite control logic levels as shown in the Truth Table.

### FEATURES

- $\pm 15$  V analog signal range
- On-resistance -  $R_{DS(on)}$ :  $15 \Omega$
- Fast switching action -  $t_{ON}$ : 110 ns
- TTL and CMOS compatible
- 8-pin CerDIP package

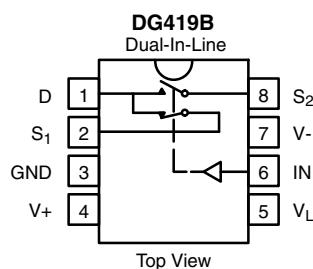
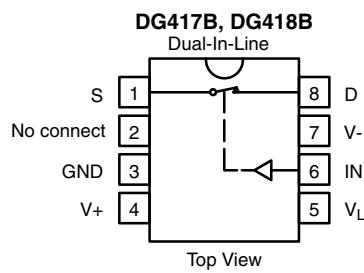
### BENEFITS

- Widest dynamic ranges
- Low signal errors and distortion
- Break-before-make switching action
- Simple interfacing
- Reduced board space
- Improved reliability

### APPLICATIONS

- Precision test equipment
- Precision instrumentation
- Battery powered systems
- Sample-and-hold circuits
- Military radios
- Hi-Rel systems
- Guidance and control systems
- Hard disk drivers

### FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



### TRUTH TABLE

LOGIC	DG417B	DG418B
0	On	Off
1	Off	On

### Notes

- Logic "0"  $\leq 0.8$  V
- Logic "1"  $\geq 2.4$  V

### TRUTH TABLE (DG419B)

LOGIC	SW <sub>1</sub>	SW <sub>2</sub>
0	On	Off
1	Off	On

### Notes

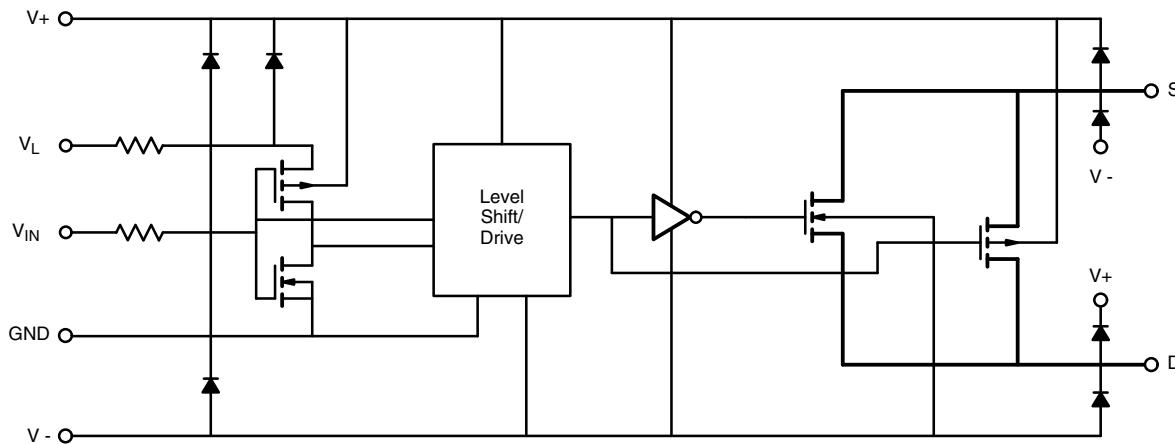
- Logic "0"  $\leq 0.8$  V
- Logic "1"  $\geq 2.4$  V

<b>ORDERING INFORMATION</b>								
PART	CONFIGURATION	TEMP. RANGE	PACKAGE	ORDERING PART	GENERIC	DSCC NUMBER		
DG417B	SPST x 1, NC	- 55 °C to 125 °C	8-pin CerDIP	9073704PA	DG417BAK/883	5962-9073704MPA		
				DG417BAK	DG417BAK	-		
				DG417BAK-E3	DG417BAK-E3	-		
	SPST x 1, NO			9073705PA	DG418BAK/883	5962-9073705MPA		
				DG418BAK	DG418BAK	-		
				DG418BAK-E3	DG418BAK-E3	-		
	SPDT x 1			9073706PA	DG419BAK/883	5962-9073706MPA		
				DG419BAK	DG419BAK	-		
				DG419BAK-E3	DG419BAK-E3	-		

<b>ABSOLUTE MAXIMUM RATINGS</b>		
PARAMETER	LIMIT	UNIT
Voltages Referenced to V-	V	V
V+	44	
GND	25	
V <sub>L</sub>	(GND - 0.3) to (V+) + 0.3	
Digital inputs <sup>a</sup> , V <sub>S</sub> , V <sub>D</sub>	(V-) - 2 V to (V+) + 2 or 30 mA, whichever occurs first	
Current, (any terminal) continuous	30	mA
Current (S or D) pulsed at 1 ms, 10 % duty cycle	100	
Storage temperature	- 65 to 150	°C
Power dissipation (package) <sup>b</sup>	8-pin CerDIP <sup>c</sup>	600 mW

**Notes**

- a. Signals on S<sub>X</sub>, D<sub>X</sub> or IN<sub>X</sub> exceeding V + or V - will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads soldered or welded to PC board.
- c. Derate 8 mW/°C above 75 °C.

**SCHEMATIC DIAGRAM** (Typical Channel)

**Fig. 1**

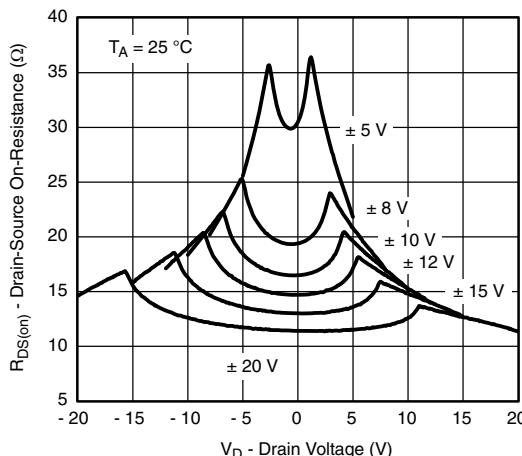
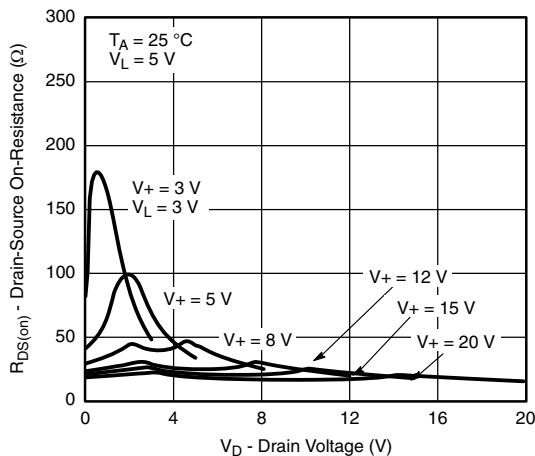
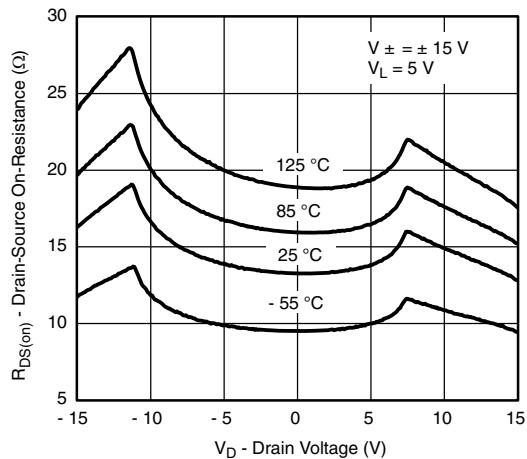
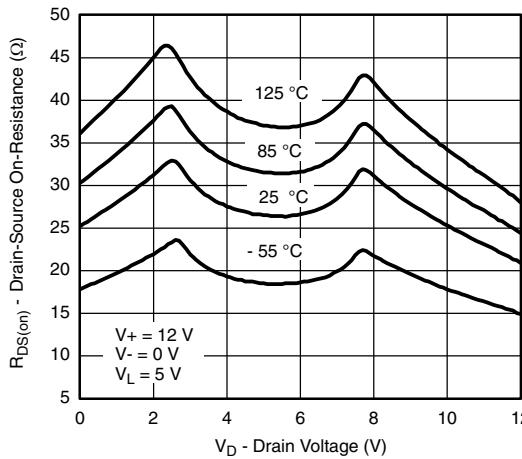
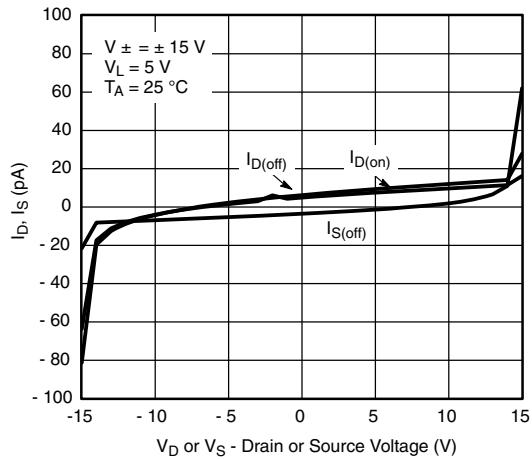
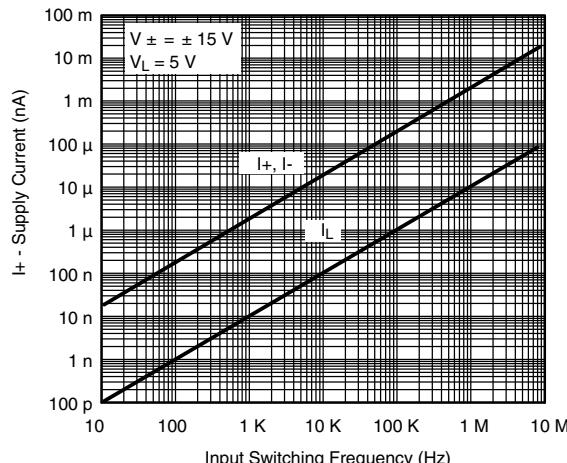
<b>SPECIFICATIONS<sup>a</sup></b>									
<b>PARAMETER</b>	<b>SYMBOL</b>	<b>TEST CONDITIONS UNLESS OTHERWISE SPECIFIED</b> $V_+ = 15 \text{ V}$ , $V_- = -15 \text{ V}$ $V_L = 5 \text{ V}$ , $V_{IN} = 2.4 \text{ V}$ , $0.8 \text{ V}^f$	<b>TEMP.<sup>b</sup></b>	<b>TYP.<sup>c</sup></b>	<b>A SUFFIX</b>		<b>UNIT</b>		
					<b>MIN.<sup>d</sup></b>	<b>MAX.<sup>d</sup></b>			
<b>Analog Switch</b>									
Analog Signal Range <sup>e</sup>	$V_{ANALOG}$		Full		-15	15	V		
Drain-Source On-Resistance	$R_{DS(on)}$	$I_S = -10 \text{ mA}$ , $V_D = \pm 12.5 \text{ V}$ $V_+ = 13.5 \text{ V}$ , $V_- = -13.5 \text{ V}$	Room	15		25	$\Omega$		
			Full	15		34			
Switch Off Leakage Current	$I_{S(off)}$	$V_+ = 16.5 \text{ V}$ , $V_- = -16.5 \text{ V}$ $V_D = \pm 15.5 \text{ V}$ , $V_S = \pm 15.5 \text{ V}$	Room	-0.1	-0.25	0.25	$nA$		
			Full	-0.1	-20	20			
			DG417B	Room	-0.1	-0.25	0.25		
			Full	-0.1	-20	20			
	$I_{D(off)}$		DG418B	Room	-0.1	-0.25	0.25		
			Full	-0.1	-20	20			
			DG419B	Room	-0.1	-0.75	0.75		
			Full	-0.1	-60	60			
Channel On Leakage Current	$I_{D(on)}$	$V_+ = 16.5 \text{ V}$ , $V_- = -16.5 \text{ V}$ $V_S = V_D = \pm 15.5 \text{ V}$	DG417B	Room	-0.4	-0.4	0.4	$\mu A$	
			Full	-0.4	-40	40			
			DG418B	Room	-0.4	-0.4	0.4		
			Full	-0.4	-40	40			
			DG419B	Room	-0.4	-0.75	0.75		
			Full	-0.4	-60	60			
<b>Digital Control</b>									
Input Current, $V_{IN}$ Low	$I_{IL}$		Full		-0.5	0.5	$\mu A$		
Input Current, $V_{IN}$ High	$I_{IH}$		Full		-0.5	0.5			
<b>Dynamic Characteristics</b>									
Turn-On Time	$t_{ON}$	$R_L = 300 \Omega$ , $C_L = 35 \text{ pF}$ $V_S = \pm 10 \text{ V}$ , see switching time test circuit	DG417B	Room	62		89	$ns$	
			Full	62			106		
Turn-Off Time	$t_{OFF}$		DG418B	Room	62		89		
			Full	62			106		
			DG417B	Room	53		80		
			Full	53			88		
Transition Time	$t_{TRANS}$	$R_L = 300 \Omega$ , $C_L = 35 \text{ pF}$ $V_{S1} = \pm 10 \text{ V}$ , $V_{S2} = \pm 10 \text{ V}$	DG419B	Room	60		87	$pC$	
			Full	60			96		
Break-Before-Make Time Delay	$t_D$	$R_L = 300 \Omega$ , $C_L = 35 \text{ pF}$ $V_{S1} = V_{S2} = \pm 10 \text{ V}$	DG419B	Room	16	3			
Charge Injection	$Q$	$C_L = 10 \text{ nF}$ , $V_{gen} = 0 \text{ V}$ , $R_{gen} = 0 \Omega$		Room	38				
Off Isolation <sup>e</sup>	$OIRR$	$R_L = 50 \Omega$ , $C_L = 5 \text{ pF}$ , $f = 1 \text{ MHz}$		Room	-82			$dB$	
Channel-to-Channel Crosstalk <sup>e</sup>	$X_{TALK}$		DG419B	Room	-88				
Source Off Capacitance <sup>e</sup>	$C_{S(off)}$	$f = 1 \text{ MHz}$ , $V_S = 0 \text{ V}$		Room	12			$pF$	
Drain Off Capacitance <sup>e</sup>	$C_{D(off)}$		DG417B	Room	12				
Channel On Capacitance <sup>e</sup>	$C_{D(on)}$		DG418B	Room	12				
			DG417B	Room	50				
			DG418B	Room	50				
			DG419B	Room	57				

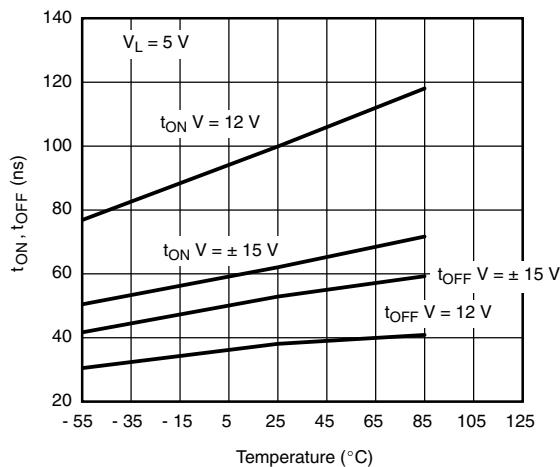
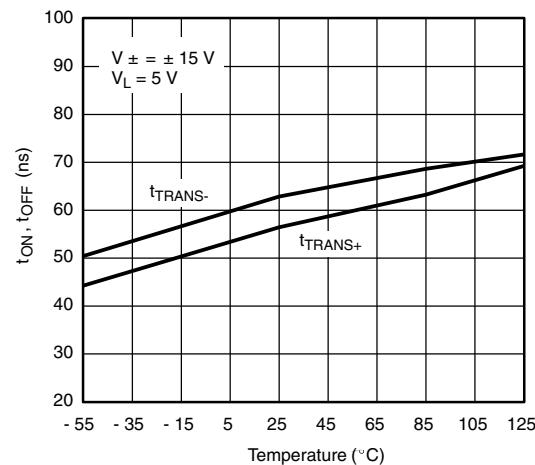
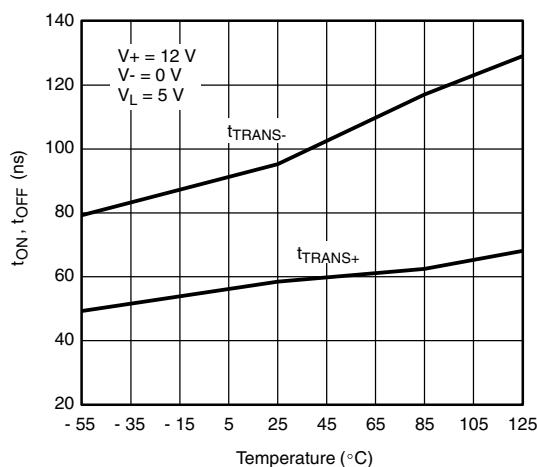
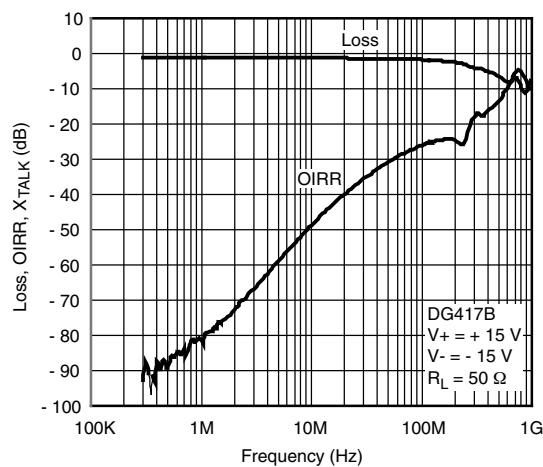
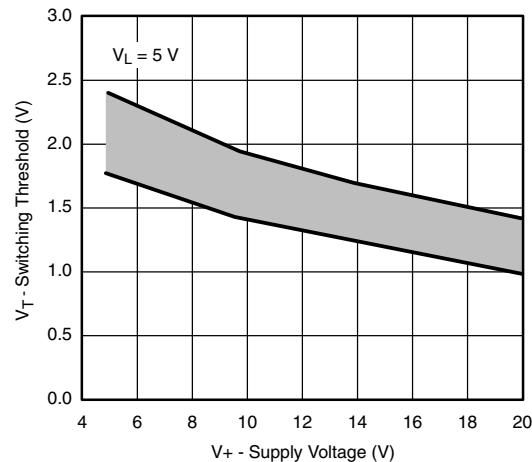
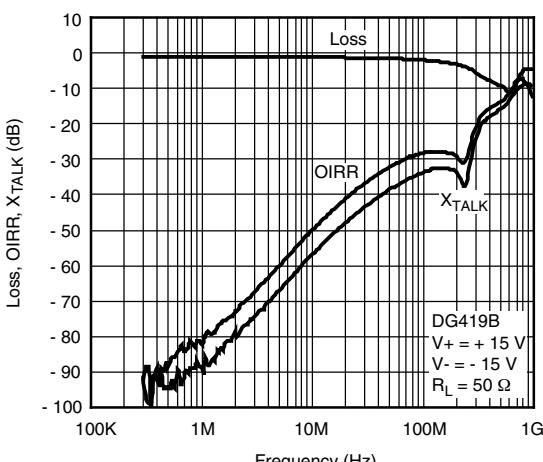
<b>SPECIFICATIONS<sup>a</sup></b>							
<b>PARAMETER</b>	<b>SYMBOL</b>	<b>TEST CONDITIONS UNLESS OTHERWISE SPECIFIED</b>		<b>TEMP.<sup>b</sup></b>	<b>TYP.<sup>c</sup></b>	<b>A SUFFIX</b>	
		$V_+ = 12 \text{ V}$ , $V_- = 0 \text{ V}$	$V_L = 5 \text{ V}$ , $V_{IN} = 2.4 \text{ V}$ , $0.8 \text{ V}^f$			$\text{MIN.}^d$	$\text{MAX.}^d$
<b>Power Supplies</b>							
Positive Supply Current	I <sub>+</sub>	$V_+ = 16.5 \text{ V}$ , $V_- = -16.5 \text{ V}$ $V_{IN} = 0 \text{ V}$ or $5 \text{ V}$	Room	0.001		1	$\mu\text{A}$
Negative Supply Current	I <sub>-</sub>		Full			5	
Logic Supply Current	I <sub>L</sub>		Room	-0.001	-1		
Ground Current	I <sub>GND</sub>		Full		-5		
			Room	0.001		1	
			Full			5	
			Room	-0.001	-1		
			Full		-5		
<b>Analog Switch</b>							
Analog Signal Range <sup>e</sup>	V <sub>ANALOG</sub>	$I_S = -10 \text{ mA}$ , $V_D = 3.8 \text{ V}$ $V_+ = 10.8 \text{ V}$	Full		0	12	V
Drain-Source On-Resistance	R <sub>DS(on)</sub>		Room	26		35	$\Omega$
			Full	26		52	
<b>Dynamic Characteristics</b>							
Turn-On Time	t <sub>ON</sub>	$R_L = 300 \Omega$ , $C_L = 35 \text{ pF}$ $V_S = 8 \text{ V}$ , see switching time test circuit	Room	100		125	$\text{ns}$
Turn-Off Time	t <sub>OFF</sub>		Full	100		155	
Break-Before-Make Time Delay	t <sub>D</sub>		Room	38		66	
Transition Time	t <sub>TRANS</sub>		Full	38		69	
Charge Injection	Q	$C_L = 10 \text{ nF}$ , $V_{gen} = 0 \text{ V}$ , $R_{gen} = 0 \Omega$		Room	18		pC
<b>Power Supplies</b>							
Positive Supply Current	I <sub>+</sub>	$V_+ = 13.2 \text{ V}$ , $V_L = 5.25 \text{ V}$ $V_{IN} = 0 \text{ V}$ or $5 \text{ V}$	Room	0.001		1	$\mu\text{A}$
Negative Supply Current	I <sub>-</sub>		Full	0.001		5	
Logic Supply Current	I <sub>L</sub>		Room	-0.001	-1		
Ground Current	I <sub>GND</sub>		Room	0.001		1	
			Room	-0.001	-1		

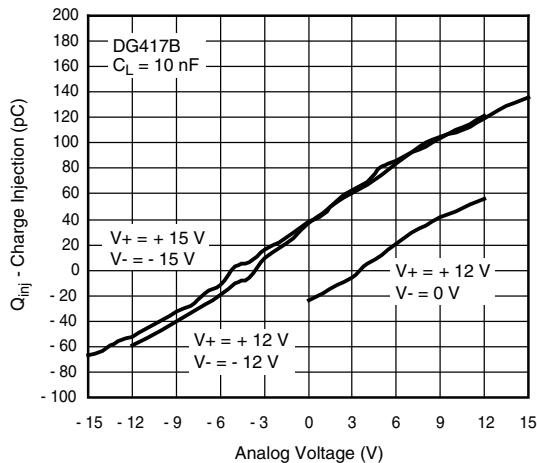
**Notes**

- a. Refer to PROCESS OPTION FLOWCHART.
- b. Room = 25 °C, full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this datasheet.
- e. Guaranteed by design, not subject to production test.
- f. V<sub>IN</sub> = input voltage to perform proper function.

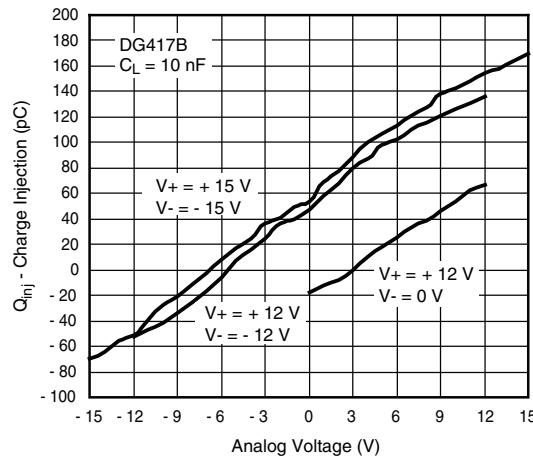
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**On-Resistance vs.  $V_D$  and Unipolar Power Supply Voltage**

**On-Resistance vs.  $V_D$  and Dual Supply Voltage**

**On-Resistance vs.  $V_D$  and Temperature**

**On-Resistance vs.  $V_D$  and Temperature**

**Leakage vs. Analog Voltage**
**Supply current vs. Input Switching Frequency**

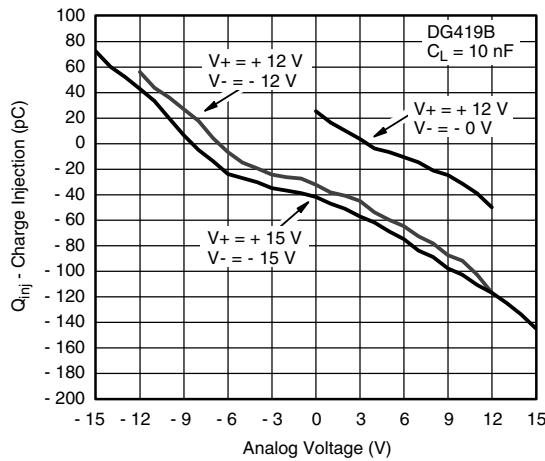
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Switching Time vs. Temperature**

**Transition Time vs. Temperature**

**Transition Time vs. Temperature**

**Insertion Loss, Off-Isolation Crosstalk vs. Frequency**

**Switching Threshold vs. Supply Voltage**

**Insertion Loss, Off-Isolation Crosstalk vs. Frequency**

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


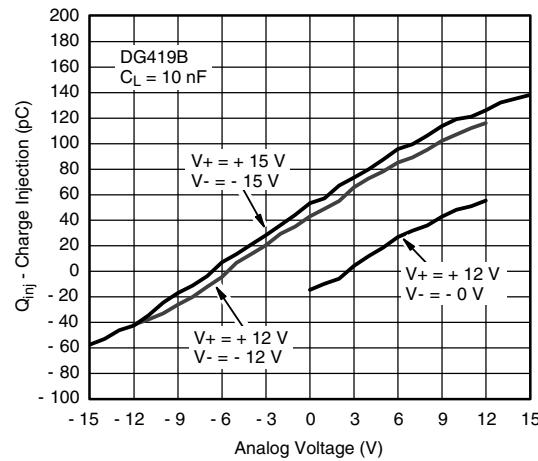
**Charge Injection vs. Analog Voltage  
(Measured at drain pin)**



**Charge Injection vs. Analog Voltage  
(Measured at source pin)**



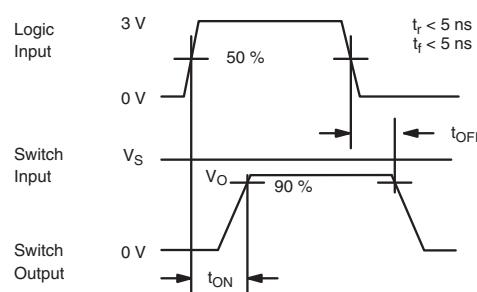
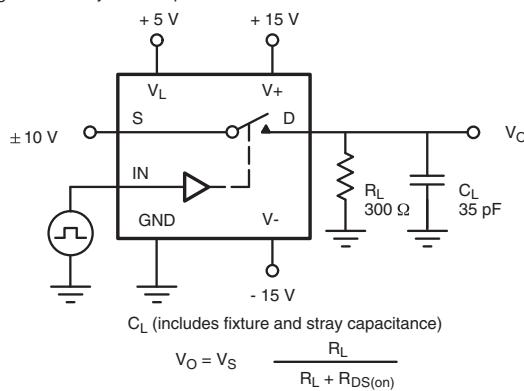
**Charge Injection vs. Analog Voltage  
(Measured at drain pin)**



**Charge Injection vs. Analog Voltage  
(Measured at source pin)**

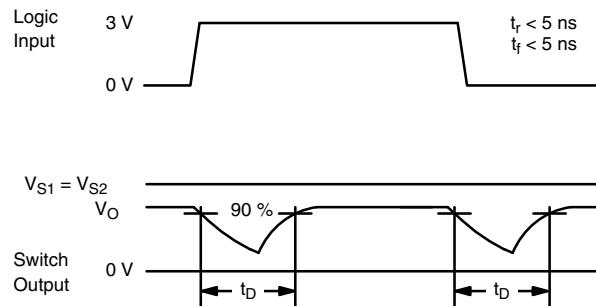
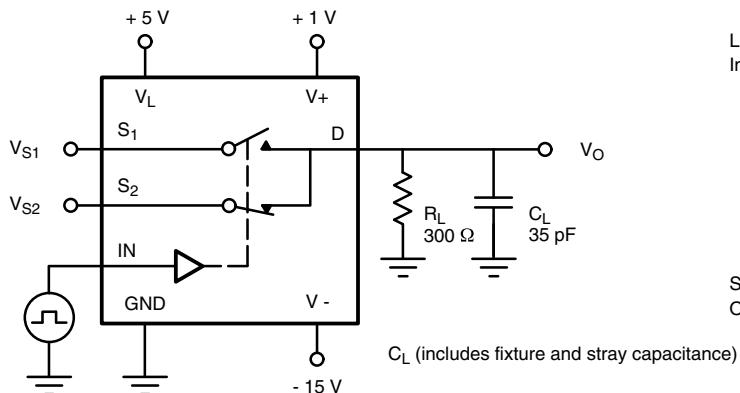
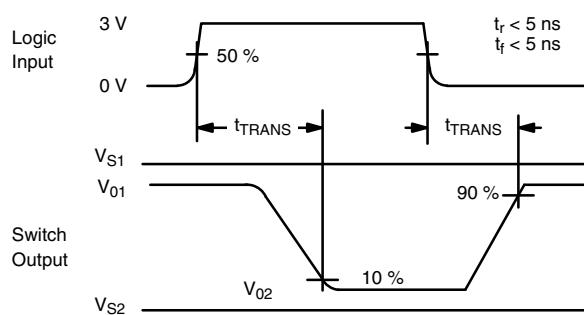
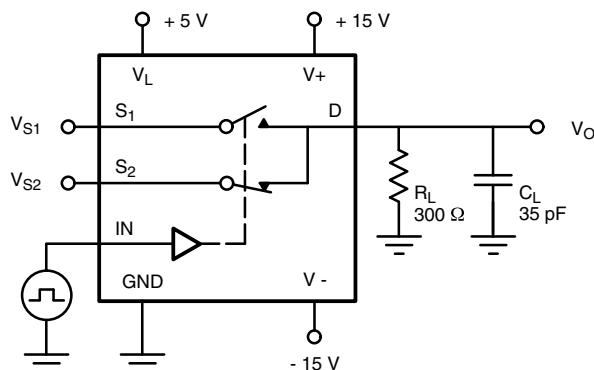
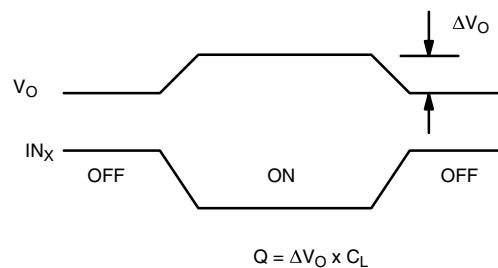
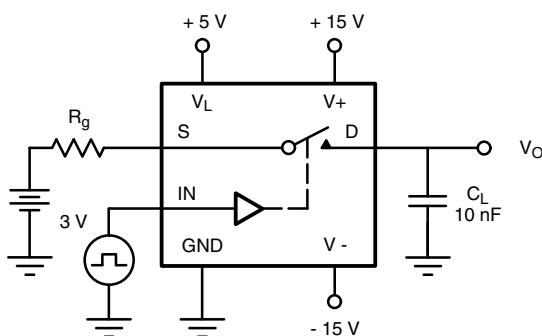
**TEST CIRCUITS**

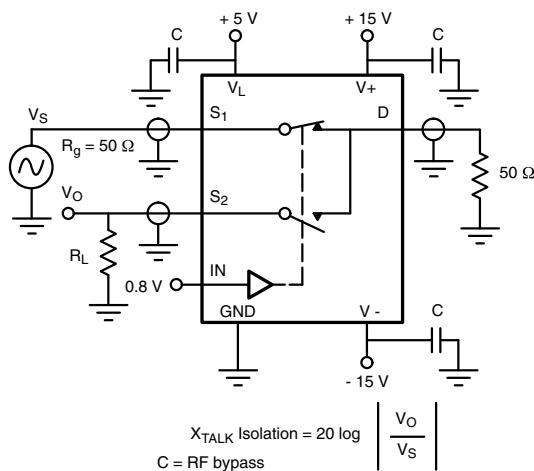
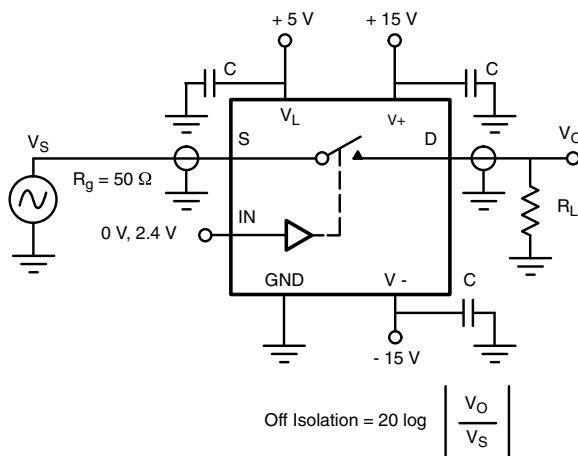
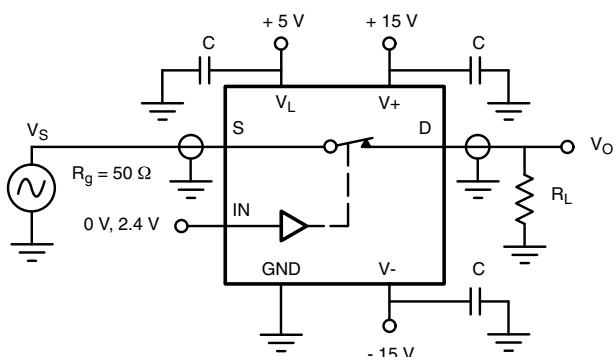
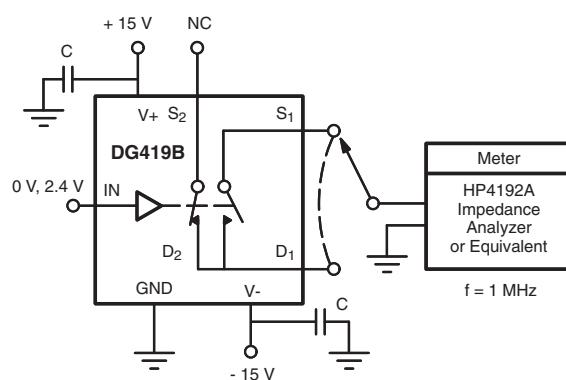
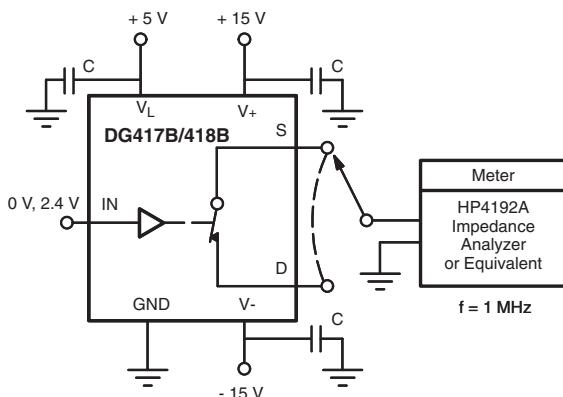
$V_O$  is the steady state output with the switch on.



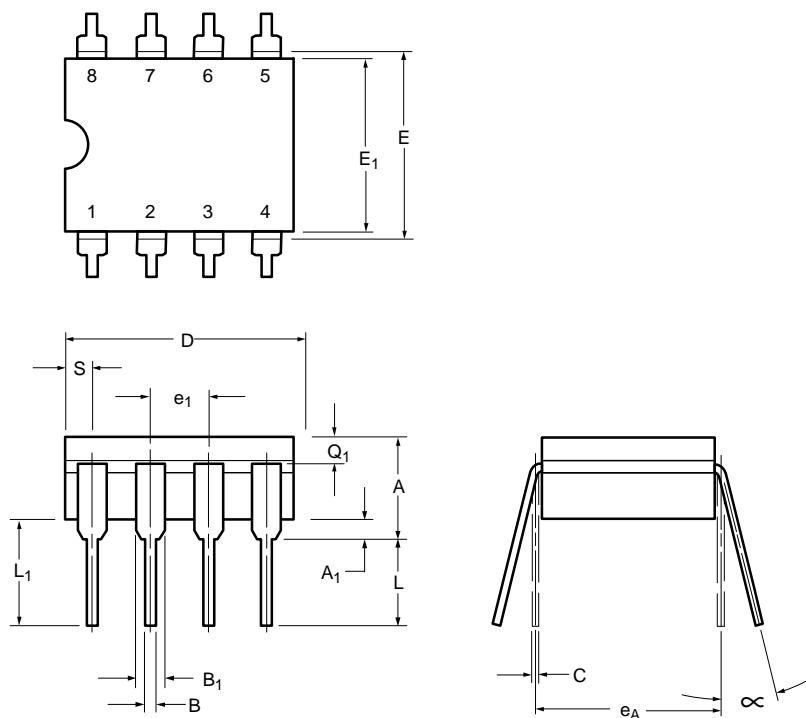
Note: Logic input waveform is inverted for switches that have the opposite logic sense.

**Fig. 2 - Switching Time (DG417B, DG418B)**

**TEST CIRCUITS**

**Fig. 3 - Break-Before-Make (DG419B)**

**Fig. 4 - Transition Time (DG419B)**

**Fig. 5 - Charge Injection**

**TEST CIRCUITS**

**Fig. 6 - Crosstalk**

**Fig. 7 - Off Isolation**

**Fig. 8 - Insertion Loss**

**Fig. 9 - Source-Drain Capacitances**

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see [www.vishay.com/ppg?63275](http://www.vishay.com/ppg?63275).

**CERDIP: 8-LEAD**


Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
<b>A</b>	4.06	5.08	0.160	0.200
<b>A<sub>1</sub></b>	0.51	1.14	0.020	0.045
<b>B</b>	0.38	0.51	0.015	0.020
<b>B<sub>1</sub></b>	1.14	1.65	0.045	0.065
<b>C</b>	0.20	0.30	0.008	0.012
<b>D</b>	9.40	10.16	0.370	0.400
<b>E</b>	7.62	8.26	0.300	0.325
<b>E<sub>1</sub></b>	6.60	7.62	0.260	0.300
<b>e<sub>1</sub></b>	2.54 BSC		0.100 BSC	
<b>e<sub>A</sub></b>	7.62 BSC		0.300 BSC	
<b>L</b>	3.18	3.81	0.125	0.150
<b>L<sub>1</sub></b>	3.18	5.08	0.150	0.200
<b>Q<sub>1</sub></b>	1.27	2.16	0.050	0.085
<b>S</b>	0.64	1.52	0.025	0.060
$\infty$	0°	15°	0°	15°

ECN: S-03946—Rev. C, 09-Jul-01  
DWG: 5348



## Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

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